PD-90875C

International **ICR** Rectifier **POWER MOSFET THRU-HOLE (TO-254AA)**

Product Summary

Part Number	RDS(on)	lD		
IRFM064	0.017 Ω	35A*		

HEXFET[®] MOSFET technology is the key to International Rectifier's advanced line of power MOSFET transistors. The efficient geometry design achieves very low on-state resistance combined with high transconductance. HEXFET transistors also feature all of the well-established advantages of MOSFETs, such as voltage control, very fast switching, ease of paralleling and electrical parameter temperature stability. They are well-suited for applications such as switching power supplies, motor controls, inverters, choppers, audio amplifiers, high energy pulse circuits, and virtually any application where high reliability is required. The HEXFET transistor's totally isolated package eliminates the need for additional isolating material between the device and the heatsink.This improves thermal efficiency and reduces drain capacitance.

IRFM064 60V, N-CHANNEL HEXFET[®] MOSFET TECHNOLOGY



Features:

- Simple Drive Requirements
- Ease of Paralleling
- Hermetically Sealed
- Electrically Isolated
- Dynamic dv/dt Rating
- Light-weight

Ał	oso	lute	N	lax	im	um	Rat	ings	
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	Parameter		Units
ID @ VGS = 10V, TC = 25°C	Continuous Drain Current	35*	
$I_D @ V_{GS} = 10V, T_C = 100^{\circ}C$	Continuous Drain Current	35*	A
IDM	Pulsed Drain Current ①	380	
P _D @ T _C = 25°C	Max. Power Dissipation	250	W
	Linear Derating Factor	2.0	W/°C
VGS	Gate-to-Source Voltage	±20	V
EAS	Single Pulse Avalanche Energy 2	620	mJ
lar	Avalanche Current ①	35	A
EAR	Repetitive Avalanche Energy ①	25	mJ
dv/dt	Peak Diode Recovery dv/dt 3	4.5	V/ns
Тј	Operating Junction	-55 to 150	
TSTG Storage Temperature Range			°C
	Lead Temperature	300 (0.063 in.(1.6mm) from case for 10s)	
	Weight	9.3 (Typical)	g

*Current is limited by package For footnotes refer to the last page

International **ISPR** Rectifier

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	Parameter	Min	Тур	Мах	Units	Test Conditions
BVDSS	Drain-to-Source Breakdown Voltage	60	—		V	$V_{GS} = 0V, I_{D} = 1.0mA$
∆BV _{DSS} /∆Tj	Temperature Coefficient of Breakdown Voltage	—	0.048	—	V/°C	Reference to 25°C, $I_D = 1.0$ mA
RDS(on)	Static Drain-to-Source On-State Resistance	—	—	0.017	Ω	VGS = 10V, ID = 35A ④
VGS(th)	Gate Threshold Voltage	2.0	—	4.0	V	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$
9fs	Forward Transconductance	21	—	_	S (7)	V _{DS} > 15V, I _{DS} = 35A ④
IDSS	Zero Gate Voltage Drain Current		—	25	μA	V _{DS} = 48V ,V _{GS} =0V
		—	—	250	μη	VDS = 48V,
						VGS = 0V, TJ = 125°C
IGSS	Gate-to-Source Leakage Forward	—	—	100	nA	$V_{GS} = 20V$
IGSS	Gate-to-Source Leakage Reverse	—	—	-100		$V_{GS} = -20V$
Qg	Total Gate Charge	—	—	240		V _{GS} =10V, I _D = 35A
Qgs	Gate-to-Source Charge	—	—	53	nC	$V_{DS} = 30V$
Qgd	Gate-to-Drain ('Miller') Charge	—	—	78		
^t d(on)	Turn-On Delay Time	—	—	27		$V_{DD} = 30V, I_D = 35A,$
tr	Rise Time	—	—	120	ns	V_{GS} =10V, R_{G} = 2.35 Ω
^t d(off)	Turn-Off Delay Time	—	—	76		
tf	Fall Time	—	—	93		
L _S + L _D	Total Inductance		6.8		nH	Measured from drain lead (6mm/ 0.25in. from package) to source lead (6mm/0.25in. from package)
C _{iss}	Input Capacitance		7400			$V_{GS} = 0V, V_{DS} = 25V$
C _{oss}	Output Capacitance		3200	_	pF	f = 1.0MHz
C _{rss}	Reverse Transfer Capacitance	—	540	—		

Electrical Characteristics @ Tj = 25°C (Unless Otherwise Specified)

Source-Drain Diode Ratings and Characteristics

	Parameter		Min	Тур	Max	Units	Test Conditions
IS	Continuous Source Current (Body Diode)		_	_	35*	Α	
ISM	Pulse Source Current (Body Diode) ①		—	—	380		
VSD	Diode Forward Voltage		—	—	3.0	V	Tj = 25°C, IS = 35A, VGS = 0V ④
t _{rr}	Reverse Recovery Time		—	—	220	nS	Tj = 25°C, IF = 35A, di/dt \leq 100A/ μ s
QRR	Reverse Recovery Charge			—	1.1	μC	$V_{DD} \le 50V $ (4)
ton	Forward Turn-On Time	Intrinsic turn-on time is negligible. Turn-on speed is substantially controlled by $LS + LD$.					

*Current is limited by package

Thermal Resistance

	Parameter	Min	Тур	Max	Units	Test Conditions
RthJC	Junction-to-Case	—	—	0.5		
RthJCS	Case-to-Sink	—	0.21	—	°C/W	
R _{thJA}	Junction-to-Ambient	—	—	48		Typical socket mount

Note: Corresponding Spice and Saber models are available on International Rectifier Website.

For footnotes refer to the last page

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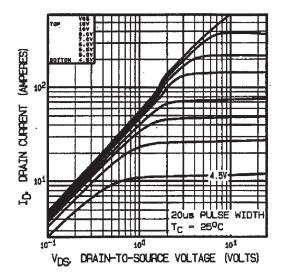


Fig 1. Typical Output Characteristics

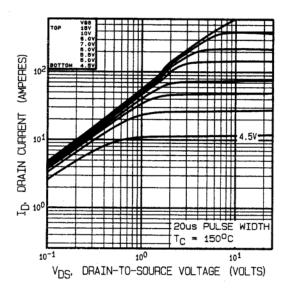


Fig 2. Typical Output Characteristics

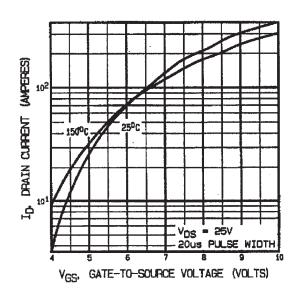


Fig 3. Typical Transfer Characteristics

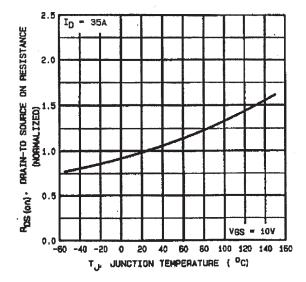


Fig 4. Normalized On-Resistance Vs. Temperature

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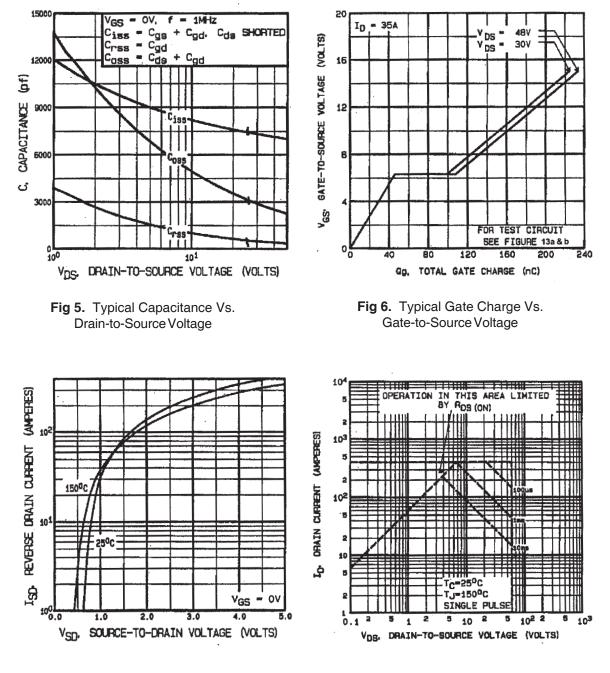
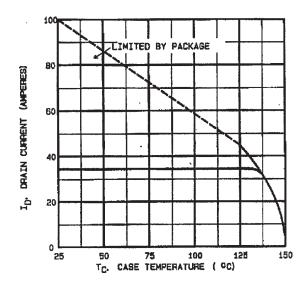
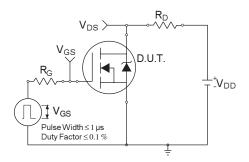


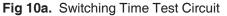
Fig 7. Typical Source-Drain Diode Forward Voltage Fig 8. Maximum Safe Operating Area

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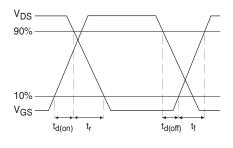


Fig 10b. Switching Time Waveforms

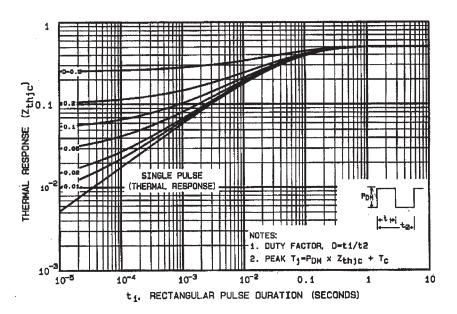


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

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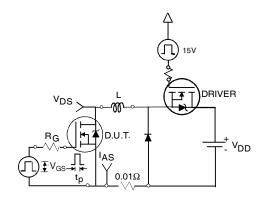


Fig 12a. Unclamped Inductive Test Circuit

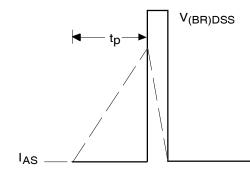


Fig 12b. Unclamped Inductive Waveforms

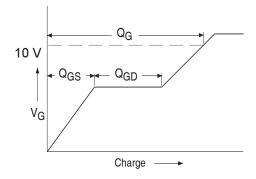


Fig 13a. Basic Gate Charge Waveform

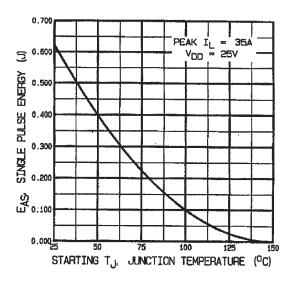


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

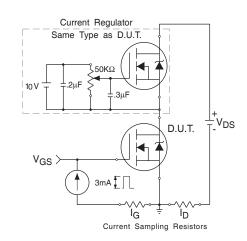


Fig 13b. Gate Charge Test Circuit

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Footnotes:

- Repetitive Rating; Pulse width limited by maximum junction temperature.
- $^{\odot}$ V_{DD} = 25V, starting T_J = 25°C, L=1.0mH Peak I_L = 35A, V_{GS} = 10V
- 3 ISD \leq 35A, di/dt \leq 300A/µs,
 - $V_{DD} \le 60V, T_{J} \le 125^{\circ}C$
- ④ Pulse width \leq 300 μ s; Duty Cycle \leq 2%
- 0.12 [.005] 13.84 [.545] 6.60 [.260] Ø 3.78 [.149] 3.53 [.139] 13.59 [.535] 6.32 [.249] 1.27 [.050] 1.02 [.040] A 20.32 [.800] 17.40 [.685] в 20.07 [.790] 13.84 [.545] 16.89 [.665] 13.59 [.535] 2 3 1 С 14.48 (.570) 0.84 (.033) 12.95 (.510) MAX. 1.14 [.045] зx Ø 0.89 [.035] 3.81 [.150] 3.81 [.150] ⊕ Ø 0.36 [.014] M B A 2X NOTES: **PIN ASSIGNMENTS** 1. DIMENSIONING & TOLERANCING PER ASME Y14.5M-1994. 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES]. 1 = DRAIN

Case Outline and Dimensions — TO-254AA

CONTROLLING DIMENSION: INCH.
CONFORMS TO JEDEC OUTLINE TO-254AA.

CAUTION

BERYLLIA WARNING PER MIL-PRF-19500

Package containing beryllia shall not be ground, sandblasted, machined, or have other operations performed on them which will produce beryllia or beryllium dust. Furthermore, beryllium oxide packages shall not be placed in acids that will produce fumes containing beryllium.

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2 = SOURCE 3 = GATE

IR WORLD HEADQUARTERS: 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105 IR LEOMINSTER : 205 Crawford St., Leominster, Massachusetts 01453, USA Tel: (978) 534-5776 TAC Fax: (310) 252-7903 Visit us at www.irf.com for sales contact information.

Data and specifications subject to change without notice. 06/2005

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单击下面可查看定价,库存,交付和生命周期等信息

>>Infineon Technologies(英飞凌)